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|----------------------------|-------------------------|--|---------------------------|-------------|
| Notice of References Cited | Application/Control No. |  | Applicant(s)/Patent Under |             |
|                            | 10/711,504              |  | Reexamination             |             |
|                            | Examiner                |  | MCKIMSON, DAVID           |             |
|                            | George D. Spisich       |  | Art Unit                  | Page 1 of 1 |
|                            | 3616                    |  |                           |             |

U.S. PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-2006/0220356                                  | 10-2006         | Baekelandt, Matthew | 280/730.2      |
| * | B | US-2004/0227334                                  | 11-2004         | Chausset, Francois  | 280/730.2      |
| * | C | US-2004/0178609                                  | 09-2004         | Totsuka et al.      | 280/730.2      |
| * | D | US-2004/0075250                                  | 04-2004         | Choi, Hyeong Ho     | 280/728.3      |
| * | E | US-6,152,482                                     | 11-2000         | Patel et al.        | 280/730.2      |
| * | F | US-6,361,069                                     | 03-2002         | Saito et al.        | 280/730.2      |
| * | G | US-6,305,707                                     | 10-2001         | Ishiyama et al.     | 280/728.2      |
| * | H | US-6,254,123                                     | 07-2001         | Urushi et al.       | 280/730.2      |
| * | I | US-6,672,027                                     | 01-2004         | Mizutani et al.     | 52/716.5       |
| * | J | US-6,530,594                                     | 03-2003         | Nakajima et al.     | 280/730.2      |
|   | K | US-  |                 |                     |                |
|   | L | US-  |                 |                     |                |
|   | M | US-  |                 |                     |                |

FOREIGN PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N | EP 1 038 736                                     | 09-2000         | Europe  |      |                |
|   | O | JP2000255370                                     | 09-2000         | Japan   |      |                |
|   | P | JP410138858                                      | 05-1998         | Japan   |      |                |
|   | Q |  |                 |         |      |                |
|   | R |  |                 |         |      |                |
|   | S |  |                 |         |      |                |
|   | T |  |                 |         |      |                |

NON-PATENT DOCUMENTS

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
|   | U |   |
|   | V |   |
|   | W |   |
|   | X |   |

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